GSM3368ADF

30V N-Channel Enhancement Mode MOSFET

Product Description

The N-Channel enhancement mode power field effect transistor is using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

The device is well suited for high efficiency fast switching applications.

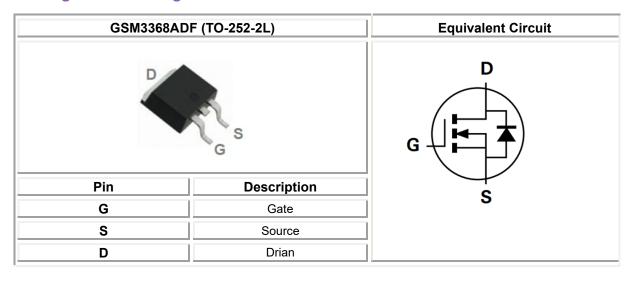
Features

- R_{DS(ON)} =6mΩ @ V_{GS}=10V
- R_{DS(ON)} =9.8mΩ @ V_{GS}=4.5V
- TO-252-2L Package
- RoHS Compliant and Halogen Free

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS

Packages & Pin Assignments



Ordering and Marking Information

Ordering Information				
Part Number	Package	Part Marking	Quantity / Reel	
GSM3368ADF	TO-252-2L	TO-252-2L 3368ADF		
GSM3368A 12				
- Product Code: GSM3368A	Package Code:- Green Level:1 is D for TO-252-2L2 is F for RoHS Compliant and Halogen Free		for RoHS Compliant	
	Marking Ir	nformation		
- Product Code: 3386ADF - GS Code:				



Symbol	Parameter		Value	Unit
VDSS	Drain-Source Voltage		30	V
Vgss	Gate-Source Voltage		±20	V
	Continuous Ducin Current 1	Tc=25°C	60	А
ID	Continuous Drain Current ^{1,}	Tc=100°C	40	
I _{DM}	Pulsed Drain Current		180	Α
I _{AS}	Single Pulse Avalanche Current, L = 0.5mH		12	Α
E _{AS}	Single Pulse Avalanche Energy, L = 0.5mH		72	mJ
		T _C =25°C	40	W
PD	Power Dissipation ^{1, 2}	T _C =100°C	16	
R _{ejc}	Thermal Resistance-Junction to Case		3	°C/W
TJ	Operating Junction Temperature Range		-55 to +150	°C
Tstg	Storage Temperature Range		-55 to +150	°C

Absolute Maximum Ratings (TJ = 25°C Unless otherwise noted)

Note: 1.The maximum current rating is limited by P_D.

2. The data tested by surface mounted on a 1 inch2 FR-4 board with 2oz copper.

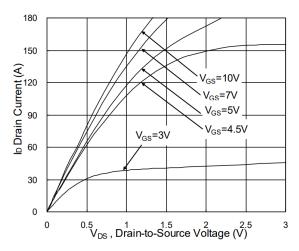
Electrical Characteristics (Tc=25°C Unless otherwise noted)

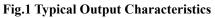
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
	Static	c characteristics				
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	30	-	-	V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.2	-	2.5	V
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =30V, V _{GS} =0V	-	-	1	μA
R _{DS(ON)} Drain-Source On-Resistance		V _{GS} =10V, I _D =15A	-	4.2	6	
	Drain-Source On-Resistance	V _{GS} =4.5V, I _D =10A	-	5.6	9.8	mΩ
Vsd	Diode Forward Voltage	V _{GS} =0V, I _S =20A	-	-	1.2	V
	Dynan	nic characteristics				
Ciss	Input Capacitance		-	2295	-	
Coss	Output Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz	-	267	-	pF
Crss	Reverse Transfer Capacitance	I- IIVII 12	-	210	-	
Rg	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f=1MHz	-	1.7	-	Ω
Qg	Total Gate Charge		-	39	-	
Q _{gs}	Gate-Source Charge	V _{DS} =15V, V _{GS} =10V, I _D =15A	-	7.6	-	nC
Q _{gd}	Gate-Drain Charge	ID-IJA	-	7.2	-	
t _{d(on)}	Turn-On Delay Time		-	7.8	-	
tr	Turn-On Rise Time	V _{DS} =15V, V _{GS} =10V,	-	15	-	
t _{d(off)}	Turn-Off Delay Time	Rg=3.3Ω, I _D =15A	-	37	-	ns
t _f	Turn-Off Fall Time		-	11	-	

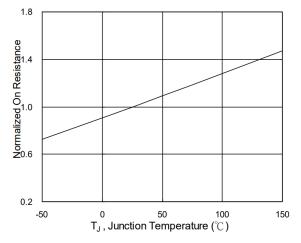
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Typical Performance Characteristics









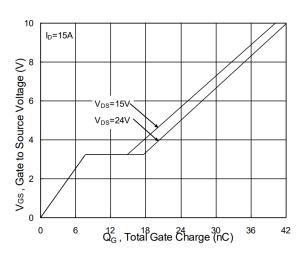
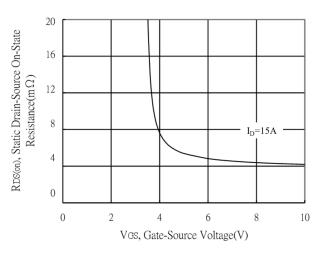


Fig.5 Gate Charge Characteristics





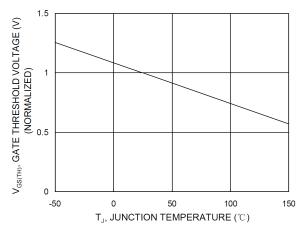
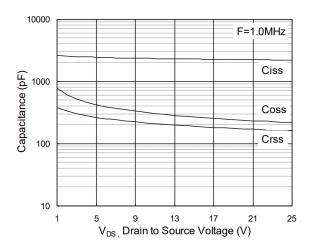
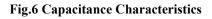


Fig.4 Normalized VGS(th) vs. TJ





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Typical Performance Characteristics

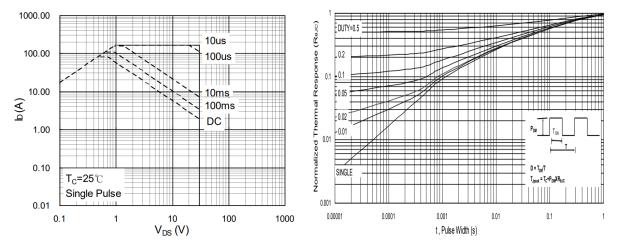


Fig.7 Maximum Safe Operation Area

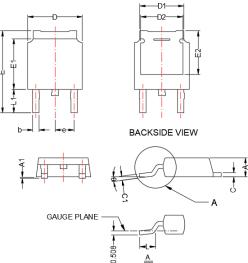
Fig.8 Normalized Transient Impedance

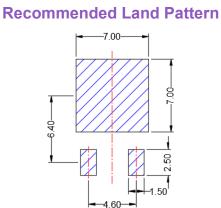


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TO-252-2L

Package Dimension

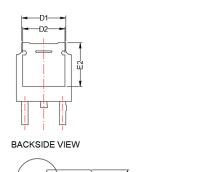




	Dimensions			
Queen al	Millimeters		Inches	
Symbol	MIN	MAX	MIN	MAX
Α	2.18	2.40	0.086	0.094
A1	0.00	0.15	0.000	0.006
b	0.64	0.90	0.025	0.035
С	0.40	0.89	0.016	0.035
c1	0.40	0.61	0.016	0.024
D	6.35	6.73	0.250	0.265
D1	4.95	5.46	0.195	0.215
D2	4.32	-	0.170	-
E	9.40	10.41	0.370	0.410
E1	5.97	6.22	0.235	0.245
E2	4.95	-	0.195	-
е	2.286 BSC		0.090 BSC	
L	1.40	1.77	0.055	0.070
L1	2.67	3.07	0.105	0.121
θ	0°	8°	0°	8°

NOTE:

Dimensions are exclusive of Burrs, Mold Flash and Tie Bar extrusions.





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